

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

MSS, Metrology Solutions Specialist, S.A. de C.V.

Almendro No. 10, Col. Naranjos Ciudad Reynosa, Tamaulipas, México. C.P. 88640

0 (Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

Dimensional, Time and Frequency, Mechanical, Electrical, Thermodynamic, Chemical, Mass, Force and Weighing Devices, Acoustic and Optical Calibration (As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Initial Accreditation Date:

Issue Date:

Expiration Date:

October 6, 2013

May 14, 2022

May 31, 2024

Accreditation No.:

Certificate No.:

76602

L22-366

Tracy Szerszen President

Perry Johnson Laboratory

Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084 The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: www.pjlabs.com





MSS, Metrology Solutions Specialist, S.A. de C.V.

Almendro No. 10, Col. Naranjos Ciudad Reynosa, Tamaulipas, México. CP. 88640 Contact Name: Hugo Geron García Phone: 899-141-9098

Accreditation is granted to the facility to perform the following testing:

Dimensional

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Micrometer ^{FO}	0.05 mm to 100 mm (Res.= 0.001 mm) 100 mm to 450 mm	$(0.74 + 3.3 \times 10^{-3} \text{L}) \mu\text{m}$ $(1.724 + 0.026 9\text{L}) \mu\text{m}$	Grade 1 Block DI-005
Dial Length Gage ^F	0.001 mm to 1 mm (Res.= 0.000 1 mm)	$(0.19 + 0.104L) \mu m$	Grade 1 Block ASME B89.1.10M
Digital Indicator ^{FO}	1 mm to 25 mm (Res.= 0.001 mm)	$(0.974 + 3.4 \times 10^{-3} L) \mu m$	Grade 1 Block ASMEB89.1.10M
Dial Indicator ^{FO}	0.0001 in to 0.005 in (Res.= 0.000 1 in)	(85 + 1.8L) μin	
Calipers ^{FO}	0.5 mm to 300 mm (Res.= 0.01 mm)	$(14.5 + 3 \times 10^{-3} L) \mu m$	
D I EO	12 in to 24 in (Res.= 0.000 5 in)	(583.8 + 4.51L) μin	Grade 3 Block DI-008
Roughness Tester ^{FO}	1.06 μm Ra (Res.= 0.001 μm) 6.07 μm Ra	0.09 μm 0.21μm	Roughness Standard Mahr PGN-3 DKD-R 4-2
Master Height Gage ^F	(Res.= 0.001 μm) 12 mm to 450 mm	$(1.2 + 0.012L) \mu m$	Grade 1 Block Comparator
Caliper Checker ^F	25 mm to 150 mm	$(1.1 + 0.011L) \mu m$	(Res.= 0.000 01) ASME B89.1.9
Z Step Gage ^F	10 mm to 150 mm	$(1.4 + 0.002L) \mu m$	
Laser Micrometer ^{FO}	0.1 in to 0.8 in 1.2 in to 1.9 in	(24 + 0.37L) μin (15.6 + 17L) μin	Master Pin Gage Class XX" DI-005
Thickness Gage ^F	23.7 µm to 966 µm	(2.7 + 0.25L) μm	Thickness Specimens Set Internal Calibration Procedure/ Reference standard: I7.2-35L / SE-797
Optical Comparator X axis Linearity Y axis Linearity ^O	0.5 mm to 50 mm 0.5 mm to 300 mm	(1.6 + 0.038L) μm (5.39 + 0.004L) μm	Glass Scale JIS B 7184
Squareness ^O	90°	0.12°	Angles Block & Quick
Optical Comparator Angularity ^O	1° to 90°	0.12°	Check 8 in JIS B 7184
Vision System Axis Linearity (X, Y) ⁰	X: 180 mm Y: 180 mm	$(3.3 + 1.2 \times 10^{-2} \text{L}) \mu\text{m}$ $(3.3 + 1.2 \times 10^{-2} \text{L}) \mu\text{m}$	Glass Grid Scale DI-001
Surface Plate Repeat Measurement ^O	0.002 in	54 μin	Repeat Gage with Precision Indicator ASME B89.3.7





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Dimensional

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Block Gage Steel ^F	0.5 mm to 100 mm	$(0.3 + 0.003L) \mu m$	Stand Block Comparator
	110 mm to 254 mm	$(0.3 + 0.005L) \mu m$	with Length Gage 1& Grade 1 Block (Res.= 0.000 01) ASME B89.1.9
Plain Plug Gage ^F	1 mm to 50 mm	(0.61 + 0.001L) μm	Laser Micrometer ASME B89.1.5
	2.54 mm to 100 mm	(0.26 + 0.004L) μm	Stand Block with Length Gage MT25 (Res.= 0.000 01) ASME B89.1.5
Plain Ring Gage ^F	14.7 mm to 100 mm	(0.68 + 0.013L) µm	Grade 1 Block with Webber Accessories (Res.= 0.001) ASME B89.1.6
Thread Plug Gage ^F	0.1 in to 1 in	(64.5 + 1.54L) μin	Thread Wire Set Class XX (Res.= 0.000 05) ASME B1.2 ASME B1.16M
Thread Ring Gage ^{FO}	0.6 in to 4 in	(55 + 7.6L) μin	Grade 1 Block with Webber Accessories (Res.= 0.000 1) ASME B1.2 ASME B1.16M
CMM Repeatability ^{FO}	8 in	68 μin	GSG Quick Check ISO 10360-2
CMM Linearity ^{FO}	5 in to 20 in	(36.3 + 11.89L) μin	Ball Bar Gage ISO 10360-2
CMM Probing Error ^{FO}	1 in	19 μin	Master Ball ISO 10360-2

Time and Frequency

Time and Trequency			
MEASURED INSTRUMENT,	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
Stopwatch ^F	86 400 sec	590 mS	Direct Comparison with
_			Cenam NIST 960-12
Angular Velocity	10 Rad/s to 4 187 Rad/s	1 % of reading	Stroboscope-Tachometer
Tachometer ^{FO}			DT2240B





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Accreditation is granted to the facility to perform the following calibration:

Mechanical

1,10011110011			
MEASURED INSTRUMENT,	RANGE OR NOMINAL DEVICE	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	SIZE AS APPROPRIATE	MEASUREMENT	EQUIPMENT
		CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
Dynamic Torque ^{FO}	10 lbf·in to 100 lbf·in	0.12 % of reading	PTT2000 Mountz with
	120 lbf·in to 1 200 lbf·in	0.09 % of reading	Transducer
	120 101 111 to 1 200 101 111	0.05 % of feating	CENAM Technical Guide

Mechanical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Torque Reaction ^{FO}	60 lbf·in to 200 lbf·in	0.42 % of reading	S-50 Mountz ASME B107.300
Pressure Gage ^{FO}	15 psi to 150 psi	$(0.07 + 1 \times 10^{-6} \text{P}) \text{ psi}$	Druk 615, Accu. 0.025 % ASME B40.1
	30 psi to 300 psi	$(0.07 + 1 \times 10^{-6} \text{P}) \text{ psi}$	Digital Pressure Test
	500 psi to 2 000 psi	$(0.25 + 2 \times 10^{-5}P) \text{ psi}$	Gages, Accu. 0.025 % ASME B40.1
	2 000 to 20 000 psi	$(12 + 3 \times 10^{-4} \text{P}) \text{ psi}$	Digital Pressure Test Gages, Accuracy 0.1 % ASME B40.1
Air Velocity Meter ^F	0.5 m/s to 15 m/s	1.1 % of reading	Thermo Anemometer (Res.= 0.01) Extech 407 113 NIST 250-79
Rockwell Hardness	20 HRB to 50 HRB	0.4 HRB	Hardness Test Block
Indirect Verification ^{FO}	51 HRB to 80 HRB	0.33 HRB	ASTM E18
	81 HRB to 100 HRB	0.38 HRB	
	20 HRC to 30 HRC	0.44 HRC	
	31 HRC to 55 HRC	0.35 HRC	
	56 HRC to 70 HRC	0.34 HRC	

Chemical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
pH Meter ^{FO}	4 pH	0.02 pH	Hanna Buffer Solutions CENAM Technical Guide
	7 pH	0.02 pH	
	10 pH	0.02 pH	Guide
Conductivity Meter ^{FO}	1 411 μs/cm	6.2 μs/cm	Hanna Buffer Solutions
	12.88 ms/cm	0.07 ms/cm	NMX-AA-093-SCFI





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Thermodynamic

11101111000 110011110			
MEASURED	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
INSTRUMENT,	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
QUANTITY OR GAUGE	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
Humidity	20 % RH to 80 % RH	2.3 % RH	Hygrometer AW
Hygrometer ^{FO}			WS-HT350
			CENAM Technical Guide

Mass, Force and Weighing Devices

MEASURED	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
INSTRUMENT,	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
QUANTITY OR GAUGE	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
QUALITITION GALGE	MINOIMETE	AS AN UNCERTAINTY (±)	STANDARDS USED
Tension and	0.5 kgf to 40 kgf	$(8 \times 10^{-3} + 8 \times 10^{-4} \text{Wt}) \text{ kg} \cdot \text{f}$	Class F1 Weight and
Compression ^{FO}			Class F Weight
			ME-013
	250 N to 2 250 N	$(0.56 + 3 \times 10-3 \text{Wt}) \text{ N}$	Daytronic Load Cell
	2001(1022001((616 6 16 11 16 6 11 16 1	ME-013
	500 kgf to 4 500 kgf	$(25.981 + 2 \times 10^{-6} \text{Wt}) \text{ kg} \cdot \text{f}$	Chatillon Load Cell
			ME-013
Scales and Balances ^O	1 g to 200 g	$(2.8 \times 10^{-4} + 1.1 \times 10^{-6} \text{Wt}) \text{ g}$	Class F1 Weights
	(Res = 0.000 1 g)		CENAM Technical Guide
	201 g to 400 g	$(22 \times 10^{-4} + 24 \times 10^{-7} \text{Wt}) \text{ g}$	
	(Res = 0.001 g)		
	401 g to 4 000 g	$(26 \times 10^{-3} + 29 \times 10^{-7} \text{Wt}) \text{ g}$	
	(Res.= 0.01 g)		
	4.1 kg to 30 kg	$(0.22 + 57 \times 10^{-7} \text{Wt}) \text{ g}$	
	(Res = 0.1 g)		
	1 lb to 100 lb	$(37 \times 10^{-4} + 25 \times 10^{-6} \text{Wt}) \text{ lb}$	Class M2 Weights
	(Res.= 0.002 lb)		CENAM Technical Guide
Scales Balances ^O	20 kg to 800 kg	$(1.7 + 22 \times 10^{-5} \text{Wt}) \text{ kg}$	
DMS 1	(Res.= 1 kg)		
Mass Calibration	1 kg	16 mg	Double Substitution Class F
Class, M2 and M3 ^F	2 kg	30 mg	1 Weights Set
	5 kg	73 mg	OIML R 111-1
	10 kg	160 mg	
	20 kg	310 mg	
	30 kg	730 mg	
	500 g	8 mg	





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Electrical

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Equipment to Output	1 mV to 200 mV	6.7 μV	Multimeter
DC Voltage ^{FO}	201 mV to 2 V	0.41 μV	8 1/2 Digit
	2.1 mV to 20 V	24 μV	Keithley Procedure El-005
	20.1 V to 200 V	5.6 mV	Troccare Er 005
	200.1 V to 1 000 V	26 mV	
Equipment to Output AC Voltage At the listed frequencies	es ^{FO}		
1 Hz to10 Hz	1 mV to 200 mV	0.36 mV	
10 Hz to 50 Hz	1 mV to 200 mV	0.17 mV	
50 Hz to100 Hz	1 mV to 200 mV	0.12 mV	
0.1 KHz to 2 KHz	1 mV to 200 mV	0.12 mV	
2 kHz to 10 kHz	1 mV to 200 mV	0.09 mV	
10 kHz to 30 kHz	1 mV to 200 mV	0.11 mV	
30 kHz to 50 kHz	1 mV to 200 mV	0.19 mV	
50 kHz to 100 kHz	1 mV to 200 mV	0.7 mV	
100 kHz to 200 kHz	1 mV to 200 mV	1.8 mV	
0.2 MHz to 1 MHz	1 mV to 200 mV	4.9 mV	
1 MHz to 2 MHz	1 mV to 200 mV	12 mV	
Equipment to Output AC Voltage At the listed frequencies	es ^{FO}		
1 Hz to 10 Hz	0.2 V to 2 V	6 mV	
10 Hz to 50 Hz	0.2 V to 2 V	1.2 mV	
50 Hz to 100 Hz	0.2 V to 2 V	0.93 mV	
0.1 Hz to 2 kHz	0.2 V to 2 V	0.93 mV	
2 kHz to10 kHz	0.2 V to 2 V	0.93 mV	
10 kHz to 30 kHz	0.2 V to 2 V	1 mV	
30 kHz to 50 kHz	0.2 V to 2 V	1.6 mV	
50 kHz to 100 kHz	0.2 V to 2 V	7.3 mV	
100 kHz to 200 kHz	0.2 V to 2 V	21 mV	
0.2 MHz to 1 MHz	0.2 V to 2 V	48 mV	
1 MHz to 2 MHz	0.2 V to 2 V	120 mV	





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Equipment to Output AC Voltage	FO	AS INVENEZATION (2)	Multimeter 8 1/2 Digit Keithley
At the listed frequencie 1Hz to 10 Hz	2 V to 20 V	29 mV	Procedure El-005
10 Hz to 50 Hz	2 V to 20 V	17 mV	
50 Hz to100 Hz	2 V to 20 V	11 mV	
0.1 kHz to 2 kHz	2 V to 20 V	72 mV	
2 kHz to 10 kHz	2 V to 20 V	12 mV	
10 kHz to 30 kHz	2 V to 20 V	15 mV	
30 kHz to 50 kHz	2 V to 20 V	25 mV	
50 kHz to 100 kHz	2 V to 20 V	73 mV	
100 kHz to 200 kHz	2 V to 20 V	180 mV	
0.2 MHz to 1 MHz	2 V to 20 V	970 mV	
1 MHz to 2 MHz	2 V to 20 V	1.7 mV	
Equipment to Output AC Voltage At the listed frequencie	cFO		
1 Hz to 10 Hz	20 V to 200 V	270 mV	
10 Hz to 50 Hz	20 V to 200 V	150 mV	
50 Hz to 100 Hz	20 V to 200 V	110 mV	
0.1 kHz to 2 kHz	20 V to 200 V	120 mV	
2 kHz to 10 kHz	20 V to 200 V	130 mV	
10 kHz to 30 kHz	20 V to 200 V	150 mV	
30 kHz to 50 kHz	20 V to 200 V	200 mV	
50 kHz to 100 kHz	20 V to 200 V	750 mV	
100 kHz to 200 kHz	20 V to 200 V	1.8 mV	
0.2 MHz to 1 MHz	20 V to 200 V	9.7 mV	
Equipment to Output AC Voltage At the listed frequencie	sFO		
1 Hz to 10 Hz	200 V to 750 V	1.3 V	
10 Hz to 50 Hz	200 V to 750 V	0.91 V	
50 Hz to 100 Hz	200 V to 750 V	0.57 V	
0.1 kHz to 2 kHz	200 V to 750 V	0.57 V	
2 kHz to 10 kHz	200 V to 750 V	0.67 V	





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Equipment to Output AC Voltage At the listed frequencies ^{FO}			Multimeter 8 1/2 Digit Keithley 2002 Procedure El-005
10 kHz to 30 kHz	200 V to 750 V	0.92 V	
30 kHz to 50 kHz	200 V to 750 V	1.1 V	
50 kHz to 100 kHz	200 V to 750 V	4.5 mV	
Equipment to Output	1 Ω to 20 Ω	1 mΩ	
Resistance - Two Wire ^{FO}	20 Ω to 200 Ω	7.2 mΩ	
	$0.2 \text{ k}\Omega$ to $2 \text{ k}\Omega$	29 mΩ	
	$2 \text{ k}\Omega \text{ to } 20 \text{ k}\Omega$	320 mΩ	
	$20~\mathrm{k}\Omega$ to $200~\mathrm{k}\Omega$	9.6 Ω	
	$0.2 \text{ M}\Omega$ to $2 \text{ M}\Omega$	190 Ω	
	$2 \text{ M}\Omega$ to $20 \text{ M}\Omega$	6.4 kΩ	
	20 MΩ to 200 MΩ	140 kΩ	
	0.2 Ω to 1 GΩ	3 ΜΩ	
Equipment to Output	1 Ω to 20 Ω	2.2 mΩ	
Resistance - Four Wire ^{FO}	20 Ω to 200 Ω	5 mΩ	
	$0.2 \text{ k}\Omega$ to $2 \text{ k}\Omega$	24 mΩ	
	$2 \text{ k}\Omega$ to $20 \text{ k}\Omega$	230 mΩ	
	$20 \text{ k}\Omega$ to $200 \text{ k}\Omega$	8.3 Ω	
	$0.2~\mathrm{M}\Omega$ to $2~\mathrm{M}\Omega$	160 Ω	
	$2 \text{ M}\Omega$ to $20 \text{ M}\Omega$	5.8 kΩ	
	$20~\mathrm{M}\Omega$ to $200~\mathrm{M}\Omega$	59 kΩ	
	$0.2~\mathrm{G}\Omega$ to $1~\mathrm{G}\Omega$	300 kΩ	
Equipment to Output	1 μA to 200 μA	90 nA	
DC Current ^{FO}	0.2 mA to 2 mA	860 nA	
	2 mA to 20 mA	8.5 μΑ	
	20 mA to 200 mA	91 μΑ	
	0.2 A to 2 A	1.8 mA	
	2 A to 10 A	190 mA	Multimeter Fluke 189 Procedure El-005





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Equipment to Output			Multimeter 8 1/2 Digit
AC Current			Keithley
At the listed frequencies ^{FO} 50 Hz to 200 Hz	1 μA to 200 μA	500 μΑ	Procedure El-005
0.2 Hz to 1 kHz	1 μA to 200 μA	960 μΑ	
1 Hz to 10 kHz	1 μA to 200 μA	1.2 μΑ	
Equipment to Output	Ι μΑ το 200 μΑ	1.2 μΑ	
AC Current At the listed frequencies FO			
20 Hz to 50 Hz	0.2 mA to 2 mA	7.3 μΑ	
50 Hz to 200 Hz	0.2 mA to 2 mA	3.8 μΑ	
0.2 Hz to 1 kHz	0.2 mA to 2 mA	3.1 μΑ	
1 kHz to 10 kHz	0.2 mA to 2 mA	3.9 μΑ	
10 kHz to 30 kHz	0.2 mA to 2 mA	6.5 μΑ	
30 kHz to 50 kHz	0.2 mA to 2 mA	7.6 μΑ	
50 kHz to100 kHz	0.2 mA to 2 mA	12 μΑ	
Equipment to Measure AC Current At the listed frequencies ^{FO}		10	
20 Hz to 50 Hz	2 mA to 20 mA	7.3 µA	
50 Hz to 200 Hz	2 mA to 20 mA	38 μΑ	
0.2 kHz to 1 kHz	2 mA to 20 mA	31 μΑ	
1 kHz to 10 kHz	2 mA to 20 mA	38 μΑ	
10 kHz to 30 kHz	2 mA to 20 mA	65 μΑ	
30 kHz to 50 kHz	2 mA to 20 mA	76 μΑ	
50 kHz to 100 kHz	2 mA to 20 mA	120 μΑ	
Equipment to Measure AC Current At the listed frequencies ^{FO}			
20 Hz to 50 Hz	20 mA to 200 mA	730 μΑ	
50 Hz to 200 Hz	20 mA to 200 mA	390 μΑ	
0.2 KHz to 1 KHz	20 mA to 200 mA	320 μΑ	
1 kHz to 10 kHz	20 mA to 200 mA	420 μΑ	
10 kHz to 30 kHz	20 mA to 200 mA	1.2 mA	





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Equipment to Measure AC Current At the listed frequencies ^{FO}			Multimeter 8 1/2 Digit Keithley Procedure El-005
30 kHz to 50 kHz	20 mA to 200 mA	2.3 mA	
50 kHz to100 kHz	20 mA to 200 mA	7 mA	
Equipment to Output AC Current At the listed frequencies ^{FO}			Multimeter 8 1/2 Digit Keithley 2002 Procedure El-005
20 Hz to 50 Hz	0.2 mA to 2 A	8.4 mA	
50 Hz to 200 Hz	0.2 mA to 2 A	5 mA	
0.2 kHz to 1 kHz	0.2 mA to 2 A	7.3 mA	
1 kHz to 10 kHz	0.2 mA to 2 A	16 mA	
10 kHz to 30 kHz	0.2 mA to 2 A	37 mA	
30 kHz to 50 kHz	0.2 mA to 2 A	94 mA	
Equipment to Output AC Voltage At the listed frequencies FO			
5 mA	1 Hz to 15 MHz	5.3 kHz	
Equipment to Output AC Current At the listed frequencies ^{FO}			
200 mA	1 Hz to 1 MHz	360 Hz	
Equipment to Output	10 Hz to 500 MHz	500 Hz	HP 5343A
frequency ^{FO}	500 MHz to 26.5 GHz	800 Hz	Procedure El-005
Equipment to Output High DC Voltage ^{FO}	6 kV	70 V	Fluke 189 / Fluke 80K - 6 HV
Equipment to Output High AC Voltage ^{FO}	6 kV	70 V	Procedure El-005
Equipment to Output	2 nF	6 pF	Standard Capacitor GRD
Capacitance ^{FO}	0.2 μF	140 pF	Procedure El-020
Temperature Calibration,	-200 °C to 0 °C	0.39 ℃	Calibrator Omega CL511
Indication and Control Equipment used with	0 °C to 100 °C	0.82 ℃	Electrical Simulation of Thermocouple Output Procedure El-020
Thermocouple Type K ^{FO}	100 °C to 1 000 °C	2.7 ℃	





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Equipment to Measure	1 mV to 330 mV	3.8 μV	Fluke 5500A
DC Voltage ^{FO}	0.33 V to 3.3 V	17 μV	Procedure El-020
	3.3 V to 33 V	180 μV	
	33 V to 330 V	12 mV	
	330 V to 1 020 V	5 mV	
Equipment to Measure AC Voltage At the listed frequencies ^{FO}			
1 Hz to 45 Hz	1 mV to 33 mV	17 μV	
45 Hz to 1 kHz	1 mV to 33 mV	17 μV	
1 kHz to 10 kHz	1 mV to 33 mV	17 μV	
10 kHz to 20 kHz	1 mV to 33 mV	17 μV	
20 kHz to 50 kHz	1 mV to 33 mV	17 μV	
50 kHz to 100 kHz	1 mV to 33 mV	17 μV	
100 kHz to 450 kHz	1 mV to 33 mV	17 μV	
Equipment to Measure AC Voltage At the listed frequencies ^{FO}		40	
1 Hz to 45 Hz	33 mV to 330 mV	120 μV	
45 Hz to 1 kHz	33 mV to 330 mV	130 μV	
1 kHz to 10 kHz	33 mV to 330 mV	130 μV	
10 kHz to 20 kHz	33 mV to 330 mV	0.9 mV	
20 kHz to 50 kHz	33 mV to 330 mV	0.9 mV	
50 kHz to 100 kHz	33 mV to 330 mV	0.9 mV	
100 kHz to 450 kHz	33 mV to 330 mV	0.9 mV	
Equipment to Measure AC Voltage At the listed frequencies ^{FO}			
1 Hz to 45 Hz	0.33 V to 3.3 V	130 mV	
45 Hz to 1 kHz	0.33 V to 3.3 V	220 mV	
1 kHz to 10 kHz	0.33 V to 3.3 V	220 mV	
10 kHz to 20 kHz	0.33 V to 3.3 V	220 mV	





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Accreditation is granted to the facility to perform the following calibration:

Electrical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Equipment to Measure			Fluke 5500A
AC Voltage			Procedure El-020
At the listed frequencies ^{FO} 1 Hz to 45 Hz	3.3 V to 330 V	130 mV	
45 Hz to 1 kHz	3.3 V to 330 V	220 mV	
1 kHz to 10 kHz	3.3 V to 330 V	220 mV	
10 kHz to 20 kHz	3.3 V to 330 V	220 mV	
Equipment to Measure AC Voltage At the listed frequencies ^{FO}			
1 Hz to 45 Hz	330 V to 1 020 V	380 mV	
45 Hz to 1 kHz	330 V to 1 020 V	450 mV	
1 kHz to 5 kHz	330 V to 1 020 V	450 mV	
5 kHz to 10 kHz	330 V to 1 020 V	450 mV	
Equipment to Measure	50 μA to 330 μA	41 nA	
DC Current ^{FO}	0.33 mA to 3.3 mA	400 nA	
	3.3 mA to 33 mA	4.6 μΑ	
	33 mA to 330 mA	90 μΑ	
	0.33 A to 2.2 A	500 μΑ	
	2.2 A to 11 A	4.3 mA	
Equipment to Measure AC Current At the listed frequencies ^{FO}			
1 Hz to 10 Hz	29 μA to 330 μA	410 nA	
10 Hz to 45 Hz	29 μA to 330 μA	350 nA	
45 Hz to 1 kHz	29 μA to 330 μA	350 nA	
1 kHz to 5 kHz	29 μA to 330 μA	350 nA	
5 kHz to 10 kHz	29 μA to 330 μA	350 nA	
Equipment to Measure AC Current At the listed frequencies ^{FO}			
1 Hz to 10 Hz	0.33 mA to 3.3 mA	2.9 μΑ	
10 Hz to 45 Hz	0.33 mA to 3.3 mA	2.5 μΑ	
45 Hz to 1 kHz	0.33 mA to 3.3 mA	2.5 μΑ	





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Equipment to Measure AC Current At the listed frequencies ^{FO}			Fluke 5500A Procedure El-020
1 kHz to 5 kHz	0.33 mA to 3.3 mA	2.5 μΑ	
5 kHz to 10 kHz	0.33 mA to 3.3 mA	2.5 μΑ	
Equipment to Measure AC Current At the listed frequencies ^{FO}			
1 Hz to 10 Hz	3.3 mA to 33 mA	31 µA	
10 Hz to 45 Hz	3.3 mA to 33 mA	460 μΑ	
45 Hz to 1 kHz	3.3 mA to 33 mA	24 μΑ	
1 kHz to 5 kHz	3.3 mA to 33 mA	24 μΑ	
5 kHz to 10 kHz	3.3 mA to 33 mA	24 μΑ	
Equipment to Measure AC Current At the listed frequencies ^{FO}			
1 Hz to 10 Hz	33 mA to 330 mA	250 μΑ	
10 Hz to 45 Hz	33 mA to 330 mA	240 μΑ	
45 Hz to 1 kHz	33 mA to 330 mA	240 μΑ	
1 kHz to 5 kHz	33 mA to 330 mA	240 μΑ	
5 kHz to 10 kHz	33 mA to 330 mA	240 μΑ	
Equipment to Measure AC Current At the listed frequencies ^{FO}			
1 Hz to 45 Hz	0.33 A to 2.2 A	2 mA	
45 Hz to 1 kHz	0.33 A to 2.2 A	2.1 mA	
1 kHz to 5 kHz	0.33 A to 2.2 A	2.1 mA	
Equipment to Measure AC Current At the listed frequencies ^{FO}			
1 Hz to 45 Hz	2.2 A to 11 A	12 mA	
45 Hz to 500 Hz	2.2 A to 11 A	12 mA	
500 Hz to 1 kHz	2.2 A to 11 A	12 mA	
Equipment to Measure	0.001 Ω to 11 Ω	1.2 mΩ	
Resistance ^{FO}	11 Ω to 33 Ω	3.6 mΩ	
	33 Ω to 110 Ω	12 mΩ	





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Equipment to Measure Resistance ^{FO}	110 Ω to 330 Ω	35 mΩ	Fluke 5500A
	033 kΩ to 1.1 kΩ	1.3 Ω	Procedure El-020
	$1.1 \text{ k}\Omega$ to $3.3 \text{ k}\Omega$	810 mΩ	
	$3.3 \text{ k}\Omega$ to $11 \text{ k}\Omega$	1.2 Ω	
	11 kΩ to 33 kΩ	3.5 Ω	
	$33 \text{ k}\Omega$ to $110 \text{ k}\Omega$	12 Ω	
	110 kΩ to 330 kΩ	35 Ω	
	0.33 MΩ to 1.1 MΩ	120 Ω	
	1.1 MΩ to 3.3 MΩ	400 Ω	
	$3.3~\mathrm{M}\Omega$ to $11~\mathrm{M}\Omega$	1.2 kΩ	
	11 MΩ to 33 MΩ	17 kΩ	
	$33 \text{ M}\Omega$ to $110 \text{ M}\Omega$	22 kΩ	
	110 MΩ to 330 MΩ	39 kΩ	
Temperature Calibration,	600 °C to 800 °C	0.84 °C	Calibrator Fluke 5500A Electrical Simulation of Thermocouple Output
Indication and Control Equipment used with	800 °C to 1 000 °C	0.63 °C	
Thermocouple Type B ^{FO}	1 000 °C to 1 400 °C	0.52 °C	Procedure El-020
	1 400 °C to 1 800 °C	0.57 °C	
Temperature Calibration,	0 °C to 600 °C	0.45 °C	
Indication and Control Equipment used with	600 °C to 1 000 °C	0.42 °C	
Thermocouple Type C ^{FO}	1 000 °C to 1 800 °C	0.61 °C	
	1 800 °C to 2 300 °C	0.63 °C	
Temperature Calibration,	-250 °C to -200 °C	0.69 °C	
Indication and Control Equipment used with Thermocouple Type E ^{FO}	-200 °C to -100 °C	0.34 °C	
	-100 °C to 100 °C	0.27 °C	
Jr. –	100 °C to 1 000 °C	0.33 °C	
Temperature Calibration,	-210 °C to -100 °C	0.39 °C	
Indication and Control Equipment used with	-100 °C to 800 °C	0.3 °C	
Thermocouple Type J ^{FO}	800 °C to 1 000 °C	0.33 °C	
1 71	1 000 °C to 1 200 °C	0.36 °C	





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Electrical

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Temperature Calibration, Indication and Control Equipment used with Thermocouple Type K ^{FO}	-250 °C to -200 °C	0.87 °C	Calibrator Fluke 5500A
	-200 °C to -100 °C	0.42 °C	Electrical Simulation of
	-100 °C to 100 °C	0.3 °C	Thermocouple Output Procedure El-020
Thermotouple Type II	100 °C to 600 °C	0.36 °C	110000010 21 020
	600 °C to 1 372 °C	0.42 °C	
Temperature Calibration,	-200 °C to -50 °C	0.4 °C	
Indication and Control	-50 °C to 200 °C	0.28 °C	
Equipment used with Thermocouple Type L ^{FO}	200 °C to 700 °C	0.31 °C	
Thermocoupie Type E	700 °C to 900 °C	0.36 °C	
Temperature Calibration,	-200 °C to -100 °C	0.51 °C	
Indication and Control	-100 °C to 900 °C	0.36 °C	
Equipment used with Thermocouple Type N ^{FO}	900 °C to 1 100 °C	0.34 °C	
Thermotouple Type IV	1 100 °C to 1 300 °C	0.37 °C	
Temperature Calibration,	-250 °C to -200 °C	0.9 ℃	
Indication and Control	-200 °C to -100 °C	0.42 °C	
Equipment used with Thermocouple Type T ^{FO}	-100 °C to 0 °C	0.34 °C	2
Thermotouple Type T	0 °C to 400 °C	0.27 °C	
Temperature Calibration,	-200 °C to -100 °C	0.27 °C	Calibrator Fluke 5500A
Indication and Control	-100 °C to 100 °C	0.19 °C	Electrical Simulation of
Equipment used with RTD, Type Pt 385, 1 $k\Omega^{FO}$	100 °C to 630 °C	0.36 °C	RTD Output Procedure El-020
	630 °C to 850 °C	0.53 °C	110000010 111 020
Temperature Calibration,	-200 °C to -100 °C	0.27 °C	
Indication and Control	-100 °C to 200 °C	0.19 ℃	
Equipment used with RTD, Type Pt 395, 100 Ω^{FO}	200 °C to 500 °C	0.36 °C	
1 ypc 1 t 393, 100 22	500 °C to 800 °C	0.53 °C	

Acoustic

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Sound Level ^F	94 dB	0.3 dB	Sound Level Calibrator EXTECH 407766 ANSI S1.4





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Accreditation is granted to the facility to perform the following calibration:

Optical

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Light MeterFO	11 lux to 5 393 lux	4.9 % of reading	Light Master EXTECH 407026 Comparison Method IS 15485

- 1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.
- 2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
- 3. The presence of a superscript F means that the laboratory performs calibration of the indicated parameter at its fixed location. Example: Outside Micrometer would mean that the laboratory performs this calibration at its fixed location.
- 4. The presence of a superscript O means that the laboratory performs calibration of the indicated parameter onsite at customer locations. Example: Outside Micrometer would mean that the laboratory performs this calibration onsite at the customer's location.
- 5. The presence of a superscript FO means that the laboratory performs calibration of the indicated parameter both at its fixed location and onsite at customer locations. Example: Outside Micrometer^{FO} would mean that the laboratory performs this calibration at its fixed location and onsite at customer locations.
- 6. Measurement uncertainties obtained for calibrations performed at customer sites can be expected to be larger than the measurement uncertainties obtained at the laboratories fixed location for similar calibrations. This is due to the effects of transportation of the standards and equipment and upon environmental conditions at the customer site which are typically not controlled as closely as at the laboratories fixed location.
- 7. The term L represents length in inches or millimeters as appropriate to the uncertainty statement.
- 8. The term P represents pressure in units appropriate to the uncertainty statement.
- 9. The term Wt represents weight in pounds or grams (including SI multiple and submultiple units) appropriate to the uncertainty statement
- 10. The term F represents Force in units appropriate to the uncertainty statement.